



Report on Radiation Damage in Fourteen Mu2e CsI Crystals

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A Brief Summary

- Two additional CsI samples (SIC-C1130 and SG-C1174) were irradiated in two steps to 10 and 100 krad. Both failed some spec after 100 krad.
- The average LO is 136 and 109 p.e./MeV after 10 and 100 krad for ten SIC crystals and 106 and 92 p.e./MeV for four S-G crystals, with losses of 19% and 35% for SIC and 30% and 39% for S-G.
- In average, slightly degraded ER, F/T ratio and LRU are observed. Two samples from each vendor show LO of <100 p.e./MeV after 100 krad.
- SIC-C1130 failed the LRU spec after 100 krad. SG-C1174 failed the LO, ER and LRU spec after 100 krad. Need to check samples from the same batch.

Summary: Ten SIC CsI Crystals

Crystal ID	Dose	L.O. (p.e./MeV)	E.R. (%)	F/T (%)	LRU (%)
SIC-C0002	Before IR	164	34	91	2.2
	10 krad	135 (82%)	35	90	0.83
	110 krad	115 (70%)	36	92	1.9
SIC-C0012	Before IR	169	33	89	2.7
	10 krad	133 (79%)	35	89	1.2
	110 krad	104 (62%)	37	90	1.5
SIC-C0202	Before IR	180	32	82	2.9
	10 krad	153 (85%)	33	86	1.0
	100 krad	112 (62%)	36	90	2.8
SIC-C0276	Before IR	196	32	86	2.9
	10 krad	169 (87%)	33	86	1.1
	100 krad	135 (69%)	35	85	1.5
SIC-C0326	Before IR	188	32	85	1.4
	10 krad	147 (78%)	34	85	1.7
	100 krad	114 (61%)	36	86	2.6
SIC-C0351	Before IR	173	33	90	2.2
	10 krad	127 (73%)	35	88	2.1
	100 krad	105 (61%)	37	91	3.5
SIC-C0438	Before IR	160	34	95	1.5
	10 krad	116 (73%)	36	92	2.6
	100 krad	95 (60%)	37	93	4.6
SIC-C0667	Before IR	137	35	80	1.4
	10 krad	111 (81%)	36	80	3.6
	100 krad	97 (71%)	37	79	4.9
SIC-C0906	Before IR	162	34	90	2.7
	10 krad	134 (83%)	35	90	5.0
	100 krad	109 (67%)	36	89	4.9
SIC-C1130	Before IR	158	34	95	4.6
	10 krad	133 (84%)	35	93	5.8
	100 krad	107 (68%)	39	96	7.9
Average (RMS)	Before IR	168 (11%)	33 (1.1)	88 (6.0%)	2.5 (1.02)
	10 krad	136 (13%)	35 (1.1)	88 (4.6%)	2.5 (1.87)
	100 krad	109 (11%)	37 (1.1)	89 (5.7%)	3.6 (2.13)

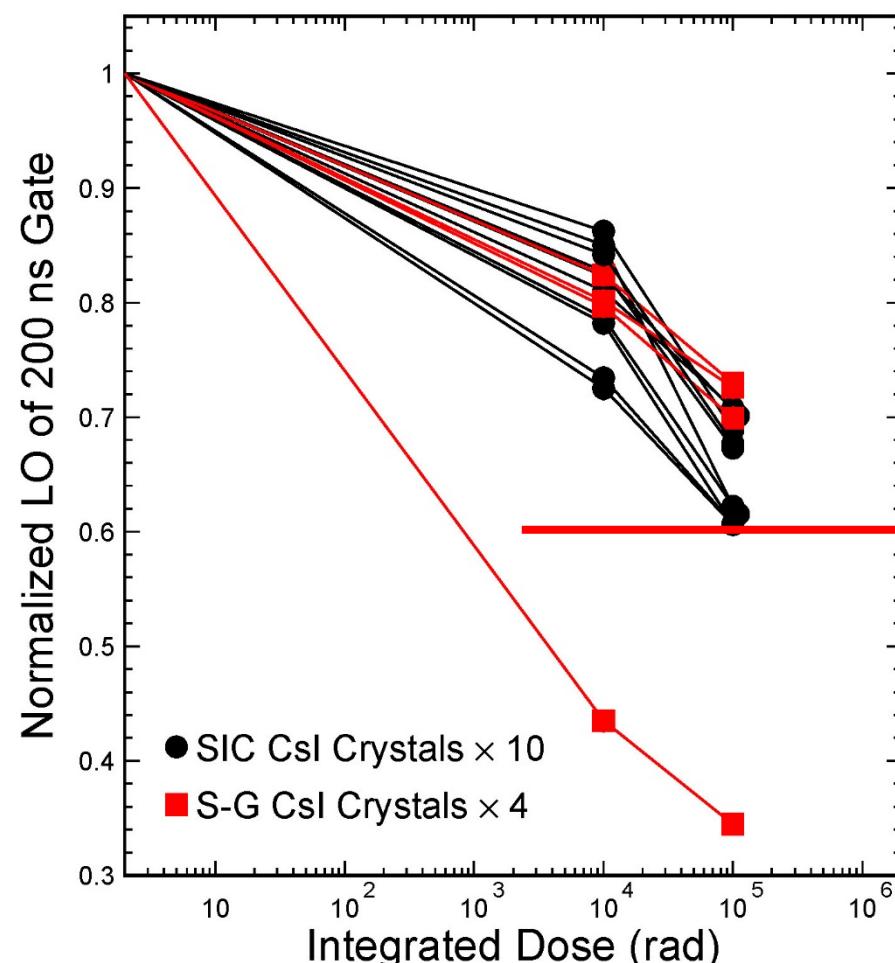
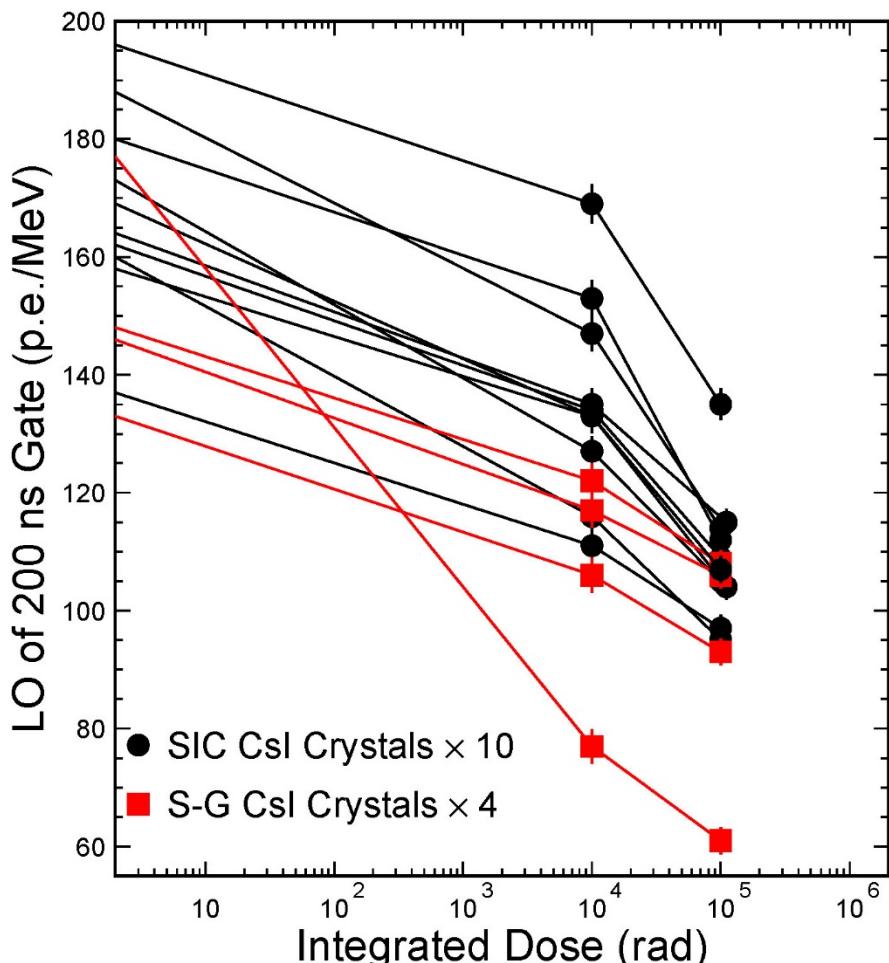
Summary: Four S-G CsI Crystals

Crystal ID	Dose	L.O. (p.e./MeV)	E.R. (%)	F/T (%)	LRU (%)
SG-C0770	Before IR	133	35	91	0.8
	10 krad	106 (80%)	36	92	1.3
	100 krad	93 (70%)	37	90	2.8
SG-C0950	Before IR	148	31	96	2.0
	10 krad	122 (82%)	34	97	3.0
	100 krad	108 (73%)	36	96	2.7
SG-C1063	Before IR	146	31	98	1.1
	10 krad	117 (80%)	34	96	2.4
	100 krad	106 (73%)	36	97	3.0
SG-C1174	Before IR	177	29	95	1.6
	10 krad	77 (44%)	42	98	5.1
	100 krad	61 (34%)	48	96	6.0
Average (RMS)	Before IR	151 (16%)	32 (1.6)	95 (2.3%)	1.4 (0.64)
	10 krad	106 (33%)	37 (6.5)	96 (1.5%)	3.0 (2.0)
	100 krad	92 (41%)	39 (9.8)	95 (0.9%)	3.6 (2.6)

Light Output vs Integrated Dose

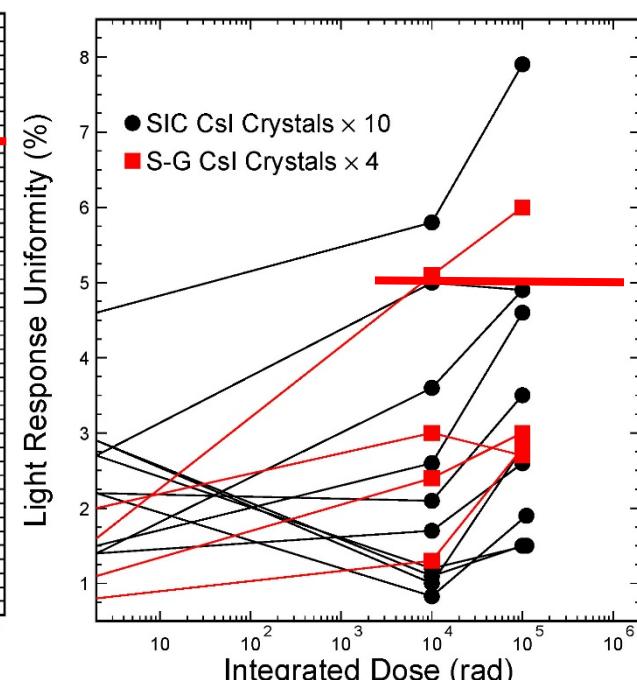
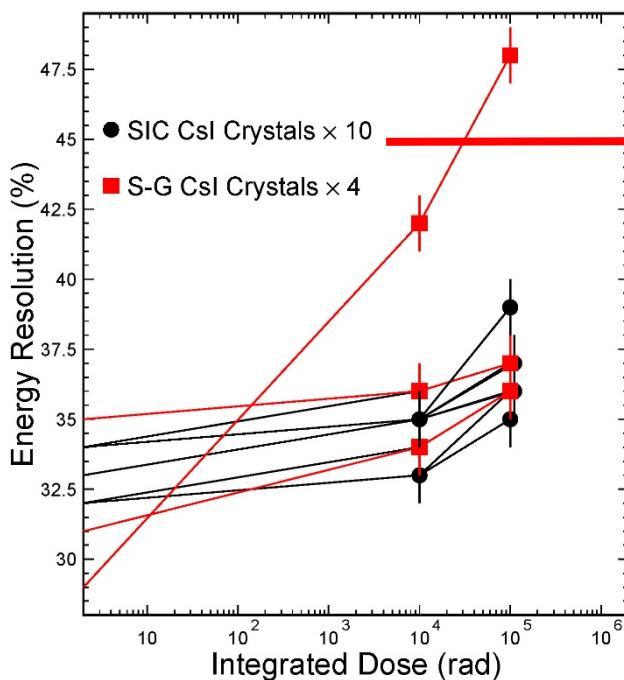
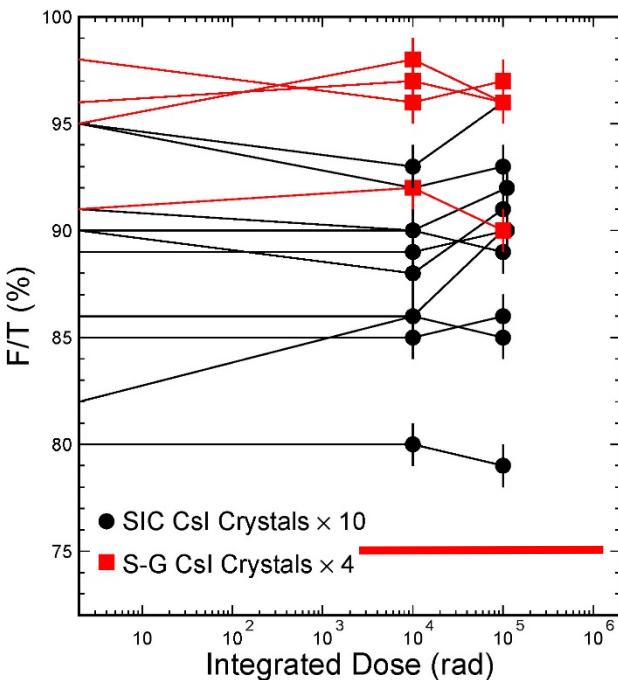
All, except four, show > 100 p.e./MeV after 100 krad

All, except one SG, meet Mu2e RH spec: > 60% after 100 krad



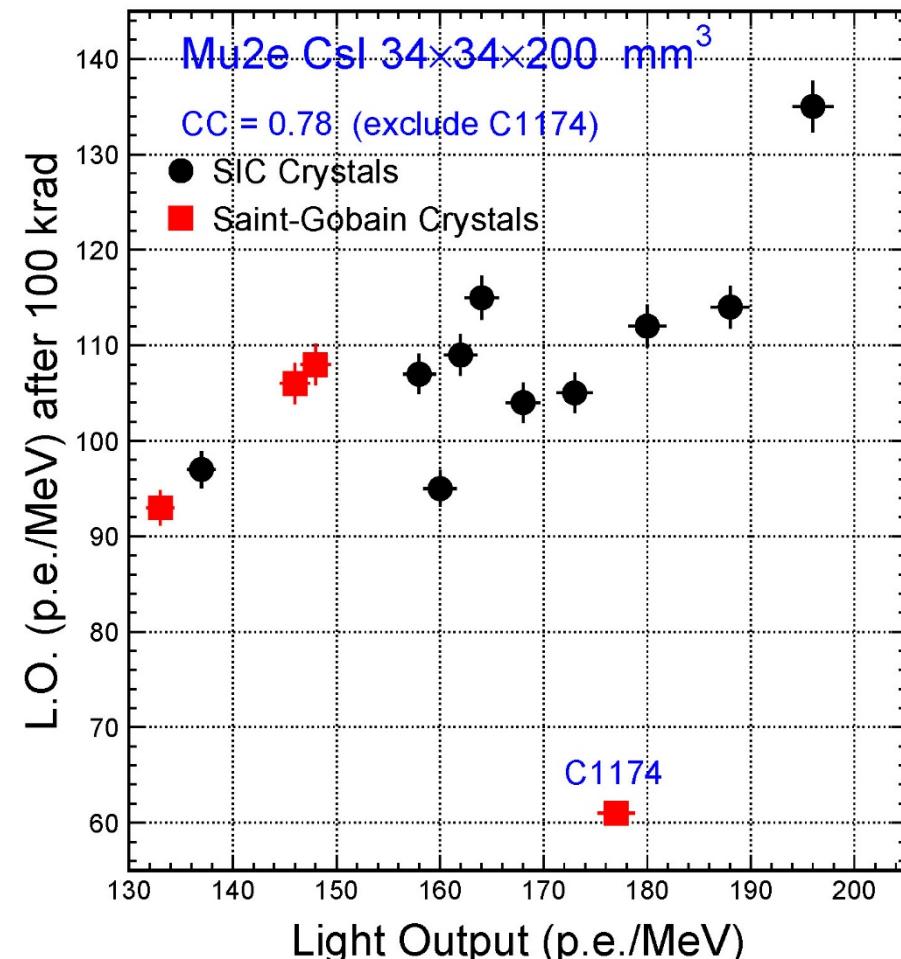
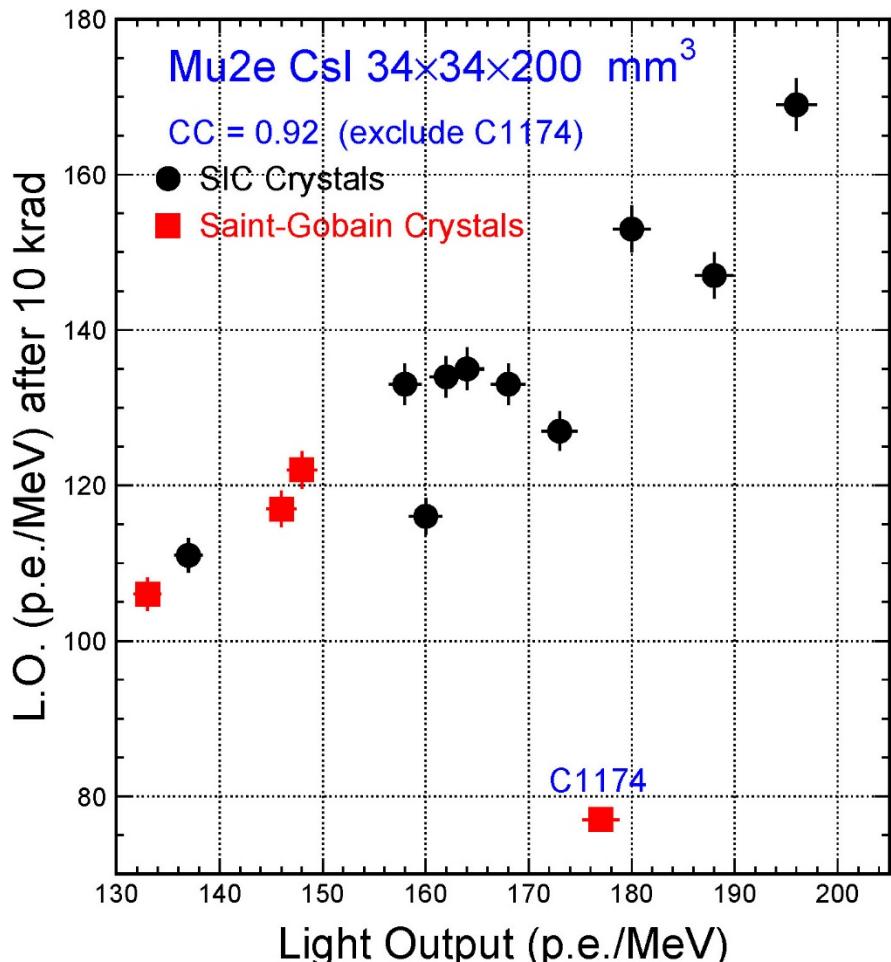
F/T, Resolution and LRU vs Integrated Dose

All, except 0, 1 and 2, meet Mu2e spec
in F/T, resolution and uniformity

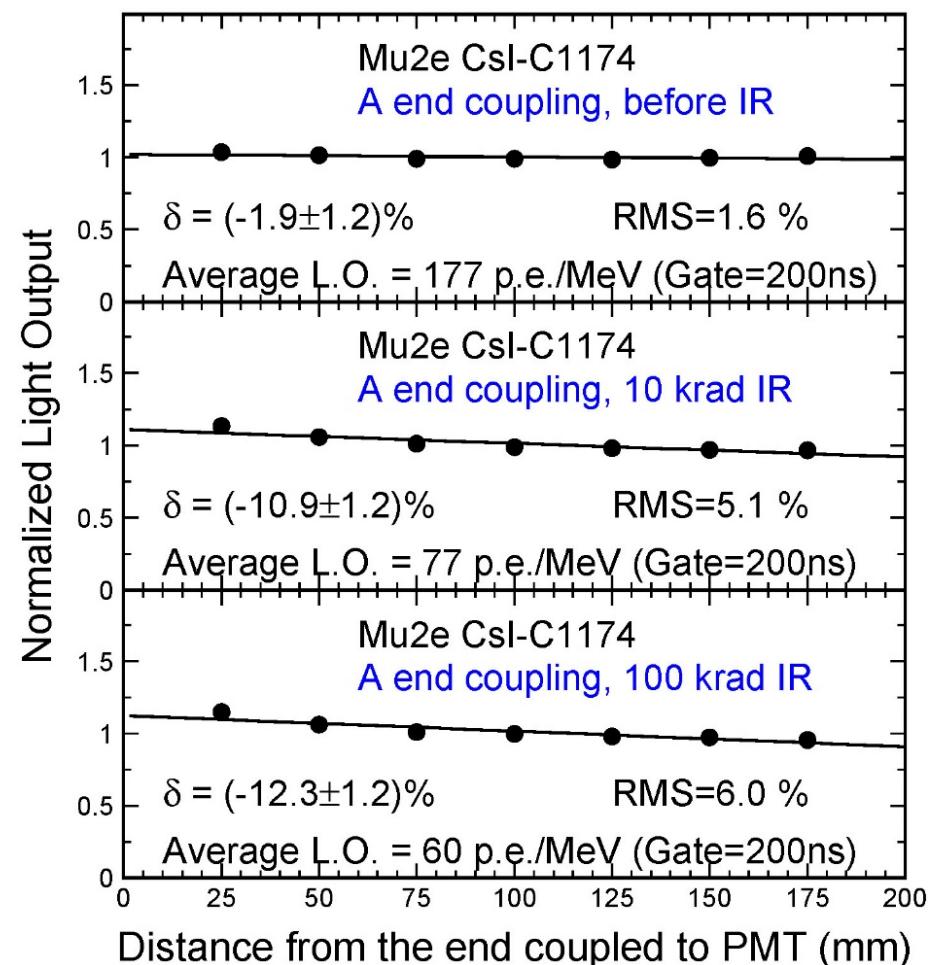
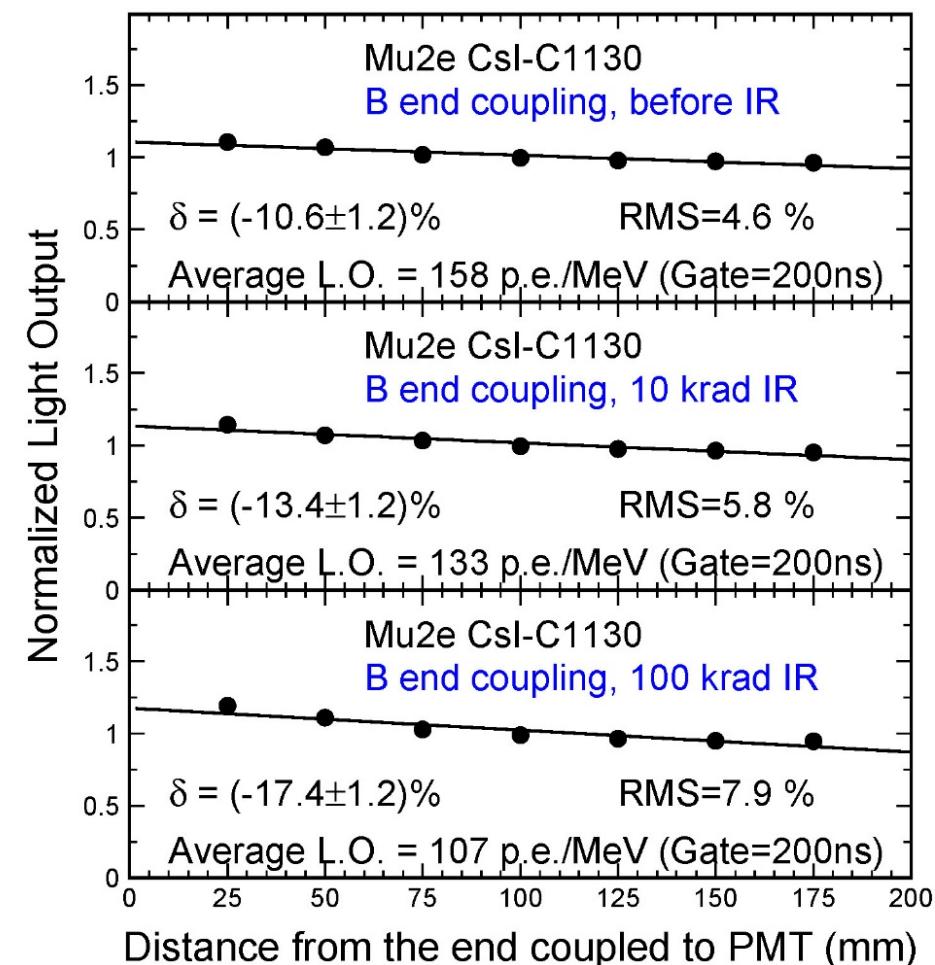


Correlations: LO_{before} vs LO_{after}

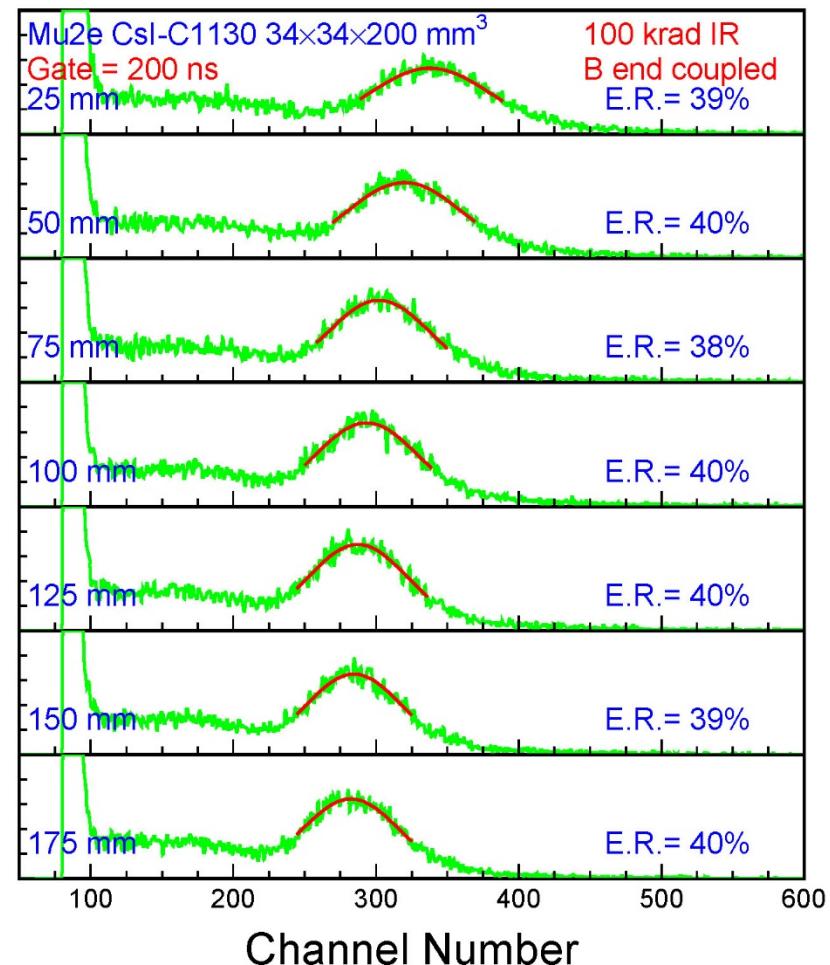
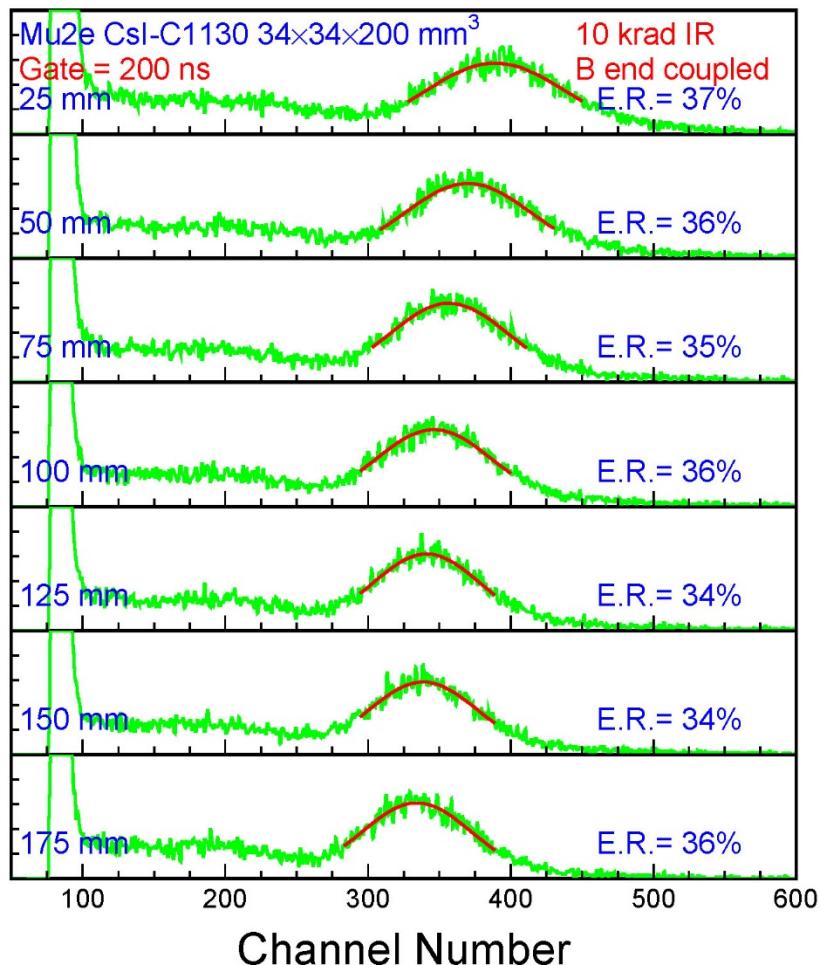
Excluding SG-C1174, good correlations observed



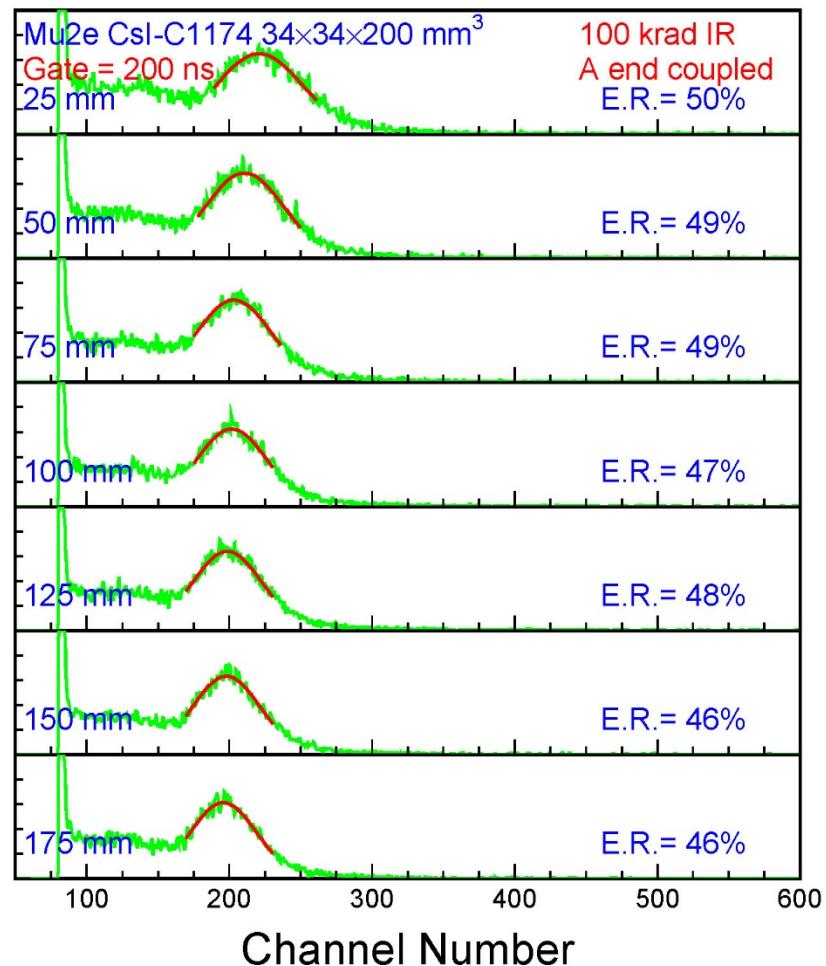
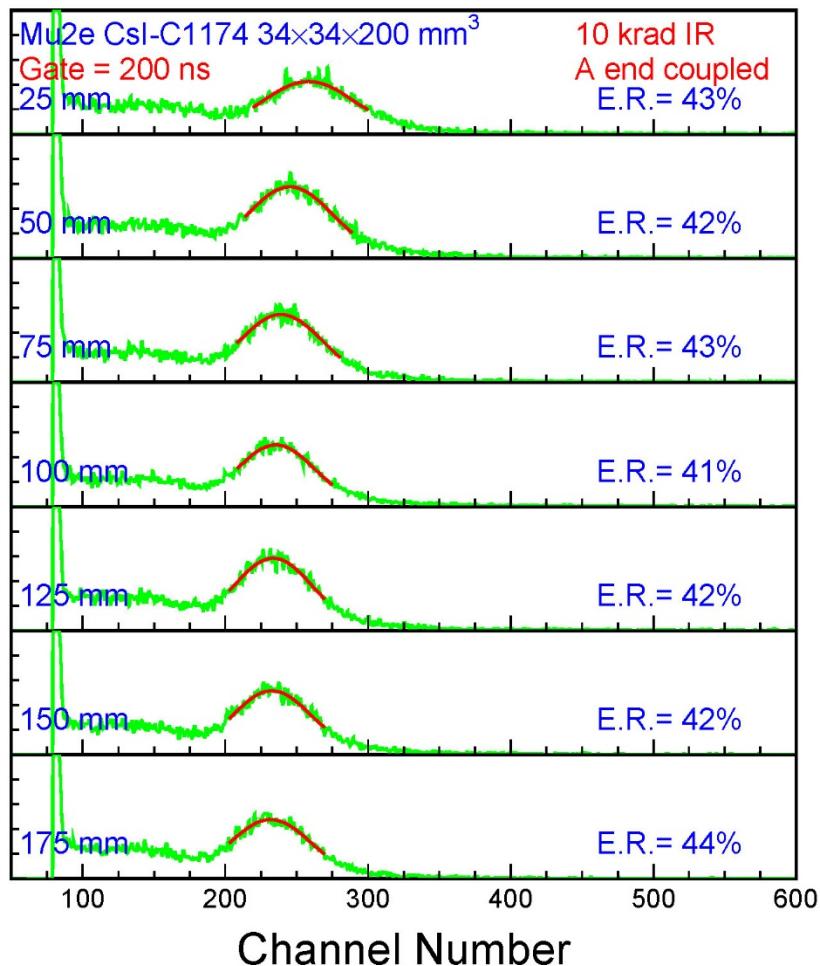
LO & LRU after γ -ray IR of 10 and 100 krad



Mu2e Pure CsI Crystal C1130 (after IR)



Mu2e Pure CsI Crystal C1174 (after IR)



Summary of Two Samples after Irradiation

Consistent results observed 14 days after 100 krad irradiation

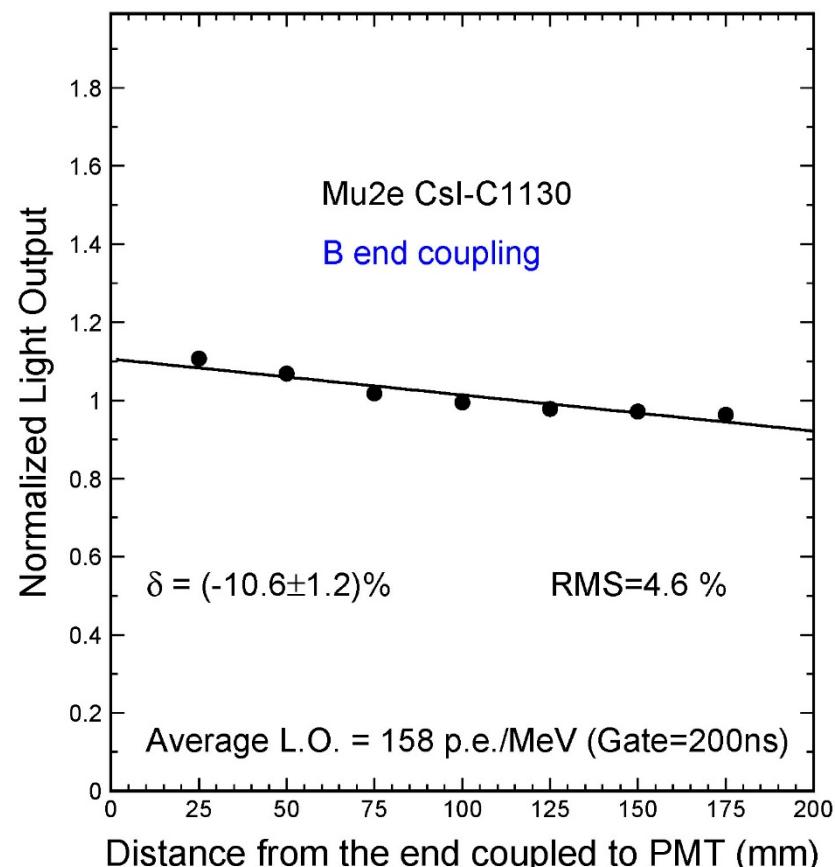
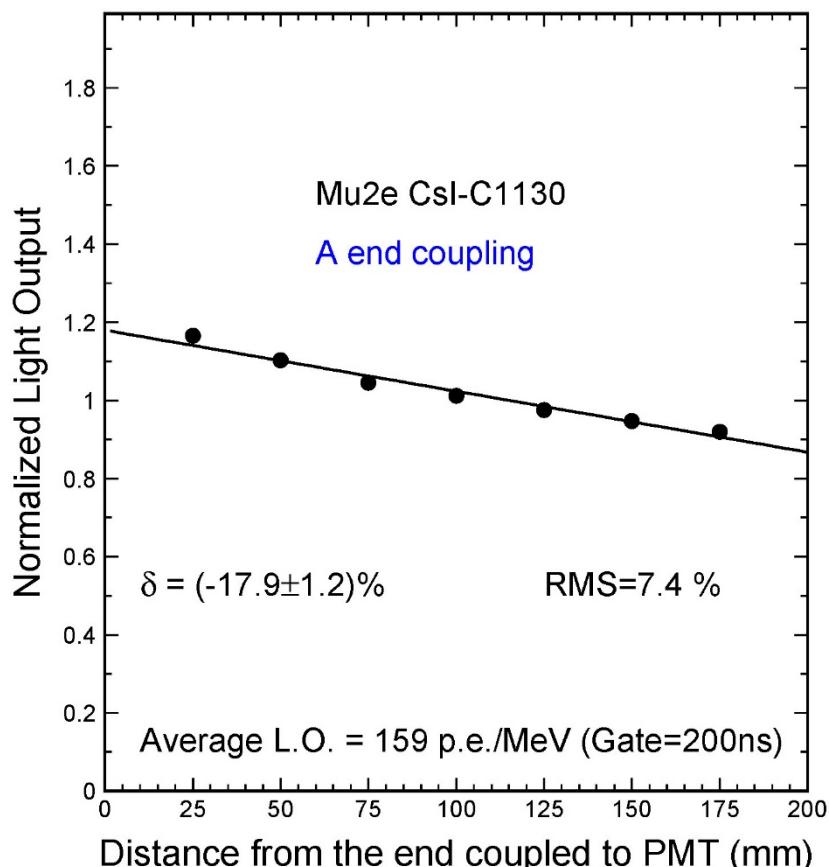
Crystal ID	Dose	L.O. (p.e./MeV)	E.R. (%)	F/T (%)	LRU (%)
SIC-C1130	Before IR	158	34	95	4.6
	10 krad	133 (84%)	35	93	5.8
	100 krad	107 (68%)	39	96	7.9
	13 days recovery	108 (68%)	39	97	9.1
SG-C1174	Before IR	177	29	95	1.6
	10 krad	77 (44%)	42	98	5.1
	100 krad	61 (34%)	48	96	6.0
	14 days recovery	68 (38%)	47	97	5.6

Samples from the same batch need to be checked

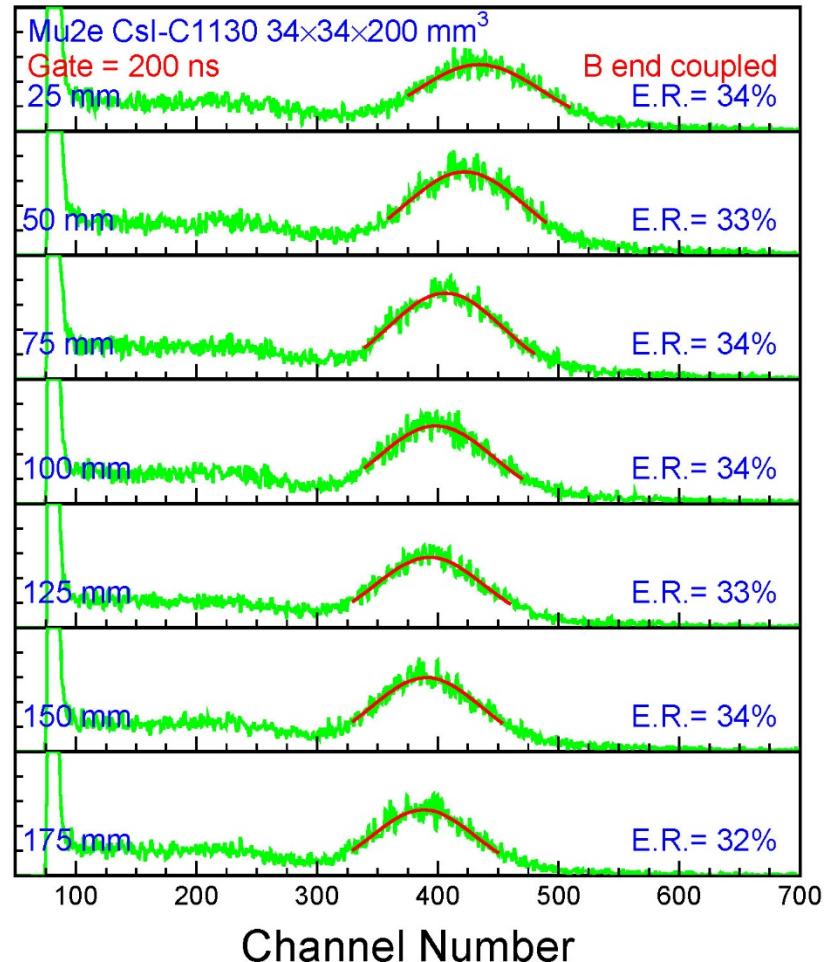
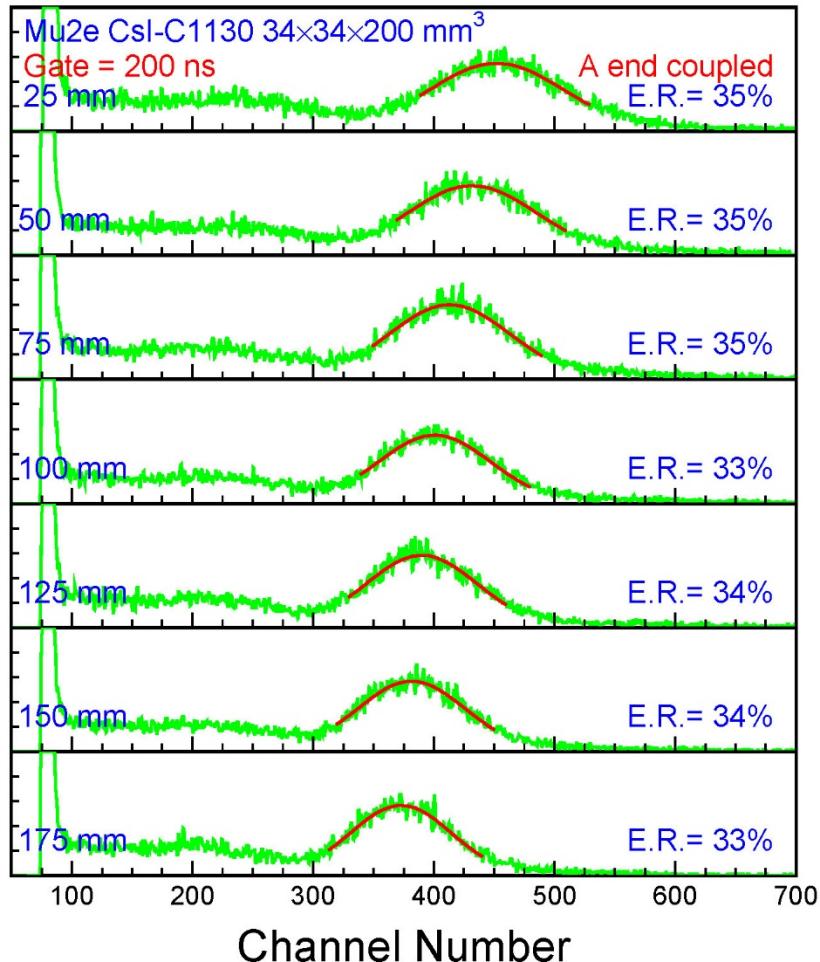
Mu2e Pure CsI Crystal C1130 (Before IR)

Crystal ID	Coupling end	L.O. (p.e./MeV)	E.R. (%)	F/T (%)	LRU (%)
C1130	A	159	34	96	7.4
	B	158	34	95	4.6

B end chosen



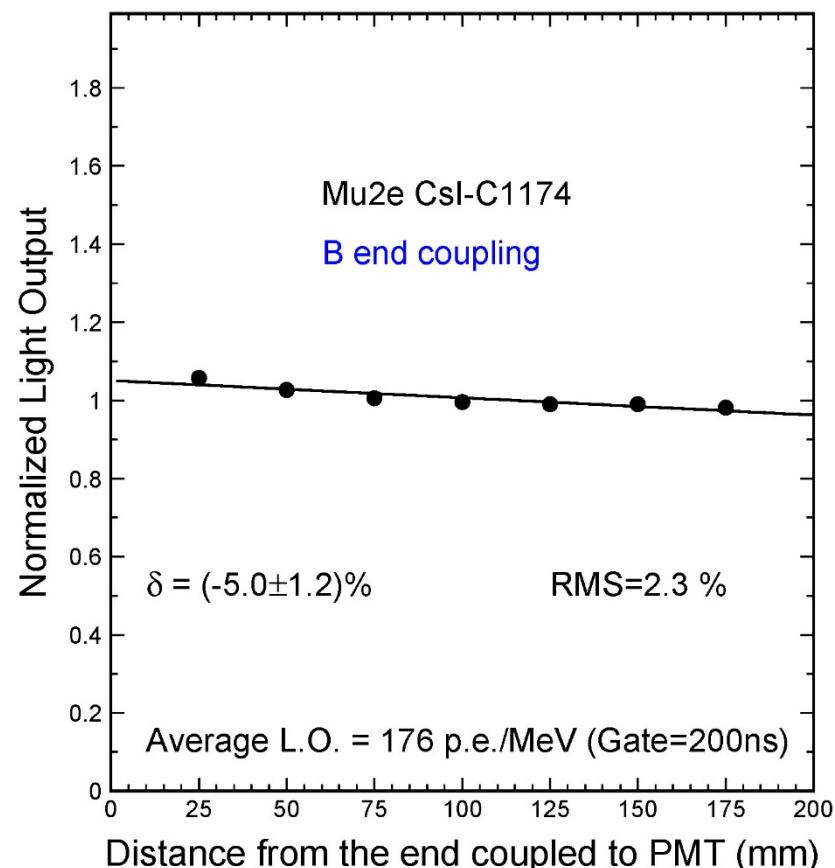
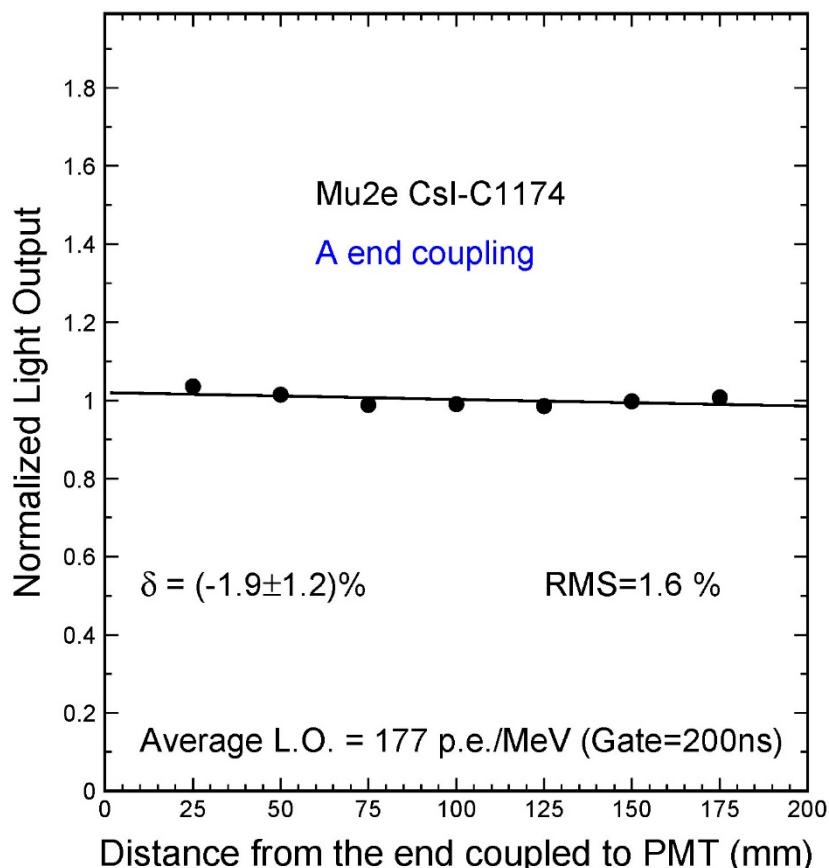
Mu2e Pure CsI Crystal C1130 (Before IR)



Mu2e Pure CsI Crystal C1174 (Before IR)

Crystal ID	Coupling end	L.O. (p.e./MeV)	E.R. (%)	F/T (%)	LRU (%)
C1174	A	177	29	95	1.6
	B	176	29	96	2.3

A end chosen



Mu2e Pure CsI Crystal C1174 (Before IR)

